



BUREAU VERITAS

Bureau Veritas Certification

Certificate of Approval

AWARDED TO

Texas Instruments Semiconductor Manufacturing (Chengdu) Co., Ltd.

No. 8-8 and No. 8-10, Kexin Road, West Zone of Chengdu Hi-Tech Industrial Development Zone, Chengdu City, Sichuan Province, 611731, China

IATF USI: CGT9P5

Bureau Veritas Certification certify that the Quality Management System of the above organisation has been audited and found to be in accordance with the requirements of

IATF 16949 - FIRST EDITION

and the applicable customer specific requirements



SCOPE

Design and manufacturing
PERMITTED EXCLUSION(S)

None

PRODUCT(S) DELIVERED

Integrated Circuits

Date Of Certification: 11-November-2024

Date Of Expiration: 10-November-2027

IATF Certificate N° : 0554551

Bureau Veritas Certification Certificate No: USA-23131/12 - IATF

Revision: 1

For Bureau Veritas Certification Holding, Tour ALTO, 4 place des saisons, 92400 COURBEVOIE - France
(The official document is in English. Any translations of this document shall be used for reference only.)





BUREAU
VERITAS

Bureau Veritas Certification



Appendix to the Certificate of Approval

AWARDED TO

Texas Instruments Semiconductor Manufacturing (Chengdu) Co., Ltd.

No. 8-8 and No. 8-10, Kexin Road, West Zone of Chengdu Hi-Tech Industrial Development Zone, Chengdu City, Sichuan Province, 611731, China

IATF USI: CGT9P5

REMOTE SUPPORT FUNCTION(S)

NAME	ADDRESS	SCOPE
Texas Instruments (India) Pvt. Ltd.	Bagmane Tech Park, # 66/3, Byrasandra, C V Raman Nagar, Bangalore, 560 093, India IATF USI: GXMKSF	Product Design
Texas Instruments Inc - DBUMP/SCT	13532 N. Central Expressway, Dallas, TX, 75243, United States IATF USI: C9FMYH	Testing
Texas Instruments Semiconductor technology (Shanghai) Co., Ltd.	2, 3F No.72 Liangxiu Road, Zhangjiang High-tech Park, Shanghai, 201203, China IATF USI: PPF69G	Engineering, Product Design, Laboratory
Texas Instruments Semiconductor technology (Shanghai) Co., Ltd. Branch	9F, 10F, 11F, New Bund Center, 555 West Haiyang Road, Pudong New Area, Shanghai, 200122, China IATF USI: CNFEE3	Sales, Marketing
Texas Instruments Semiconductor Technology (Shanghai) Co., Ltd. - Shanghai Device Analysis Operation	4F, Building 2, 615 NingQiao Rd., Pudong New Area, Shanghai, 201206, China IATF USI: G6A5HE	Laboratory

Date Of Certification: 11-November-2024

Date Of Expiration: 10-November-2027

IATF Certificate N° : 0554551

Bureau Veritas Certification Certificate No: USA-23131/12 - IATF

Revision: 1

For Bureau Veritas Certification Holding, Tour ALTO, 4 place des saisons, 92400 COURBEVOIE - France
(The official document is in English. Any translations of this document shall be used for reference only.)





BUREAU
VERITAS

Bureau Veritas Certification



Appendix to the Certificate of Approval

AWARDED TO

Texas Instruments Semiconductor Manufacturing (Chengdu) Co., Ltd.

No. 8-8 and No. 8-10, Kexin Road, West Zone of Chengdu Hi-Tech Industrial Development Zone, Chengdu City, Sichuan Province, 611731, China

IATF USI: CGT9P5

REMOTE SUPPORT FUNCTION(S)

NAME	ADDRESS	SCOPE
Texas Instruments, Inc. - North Campus Support	13121 TI Blvd., Dallas, TX, 75243, United States IATF USI: 6E9WYZ	Engineering, Process Design, Purchasing, Logistics, Supplier Management, Laboratory
Texas Instruments, Inc. - Semiconductor Group Headquarters - South Campus	12500 TI Blvd, Dallas, TX, 75243, United States IATF USI: 3E9YYA	Product Design, Engineering, Laboratory, Testing, Human Resources, Marketing, Policy Making, Internal Audit Management, Quality System Management, Information Technologies, Strategic Planning
Texas Instruments, Inc. - TMG Top Management	13121 TI Blvd, Dallas, Texas, 75243, United States IATF USI: CF99Y6	Strategic Planning, Policy Making

Date Of Certification: **11-November-2024**

Date Of Expiration: **10-November-2027**

IATF Certificate N°: **0554551**

Bureau Veritas Certification Certificate No: **USA-23131/12 - IATF**

Revision: **1**

For Bureau Veritas Certification Holding, Tour ALTO, 4 place des saisons, 92400 COURBEVOIE - France
(The official document is in English. Any translations of this document shall be used for reference only.)



IMPORTANT NOTICE AND DISCLAIMER

TI PROVIDES TECHNICAL AND RELIABILITY DATA (INCLUDING DATA SHEETS), DESIGN RESOURCES (INCLUDING REFERENCE DESIGNS), APPLICATION OR OTHER DESIGN ADVICE, WEB TOOLS, SAFETY INFORMATION, AND OTHER RESOURCES "AS IS" AND WITH ALL FAULTS, AND DISCLAIMS ALL WARRANTIES, EXPRESS AND IMPLIED, INCLUDING WITHOUT LIMITATION ANY IMPLIED WARRANTIES OF MERCHANTABILITY, FITNESS FOR A PARTICULAR PURPOSE OR NON-INFRINGEMENT OF THIRD PARTY INTELLECTUAL PROPERTY RIGHTS.

These resources are intended for skilled developers designing with TI products. You are solely responsible for (1) selecting the appropriate TI products for your application, (2) designing, validating and testing your application, and (3) ensuring your application meets applicable standards, and any other safety, security, regulatory or other requirements.

These resources are subject to change without notice. TI grants you permission to use these resources only for development of an application that uses the TI products described in the resource. Other reproduction and display of these resources is prohibited. No license is granted to any other TI intellectual property right or to any third party intellectual property right. TI disclaims responsibility for, and you will fully indemnify TI and its representatives against, any claims, damages, costs, losses, and liabilities arising out of your use of these resources.

TI's products are provided subject to [TI's Terms of Sale](#) or other applicable terms available either on [ti.com](https://www.ti.com) or provided in conjunction with such TI products. TI's provision of these resources does not expand or otherwise alter TI's applicable warranties or warranty disclaimers for TI products.

TI objects to and rejects any additional or different terms you may have proposed.

Mailing Address: Texas Instruments, Post Office Box 655303, Dallas, Texas 75265
Copyright © 2024, Texas Instruments Incorporated